

# First look at data and detector performances

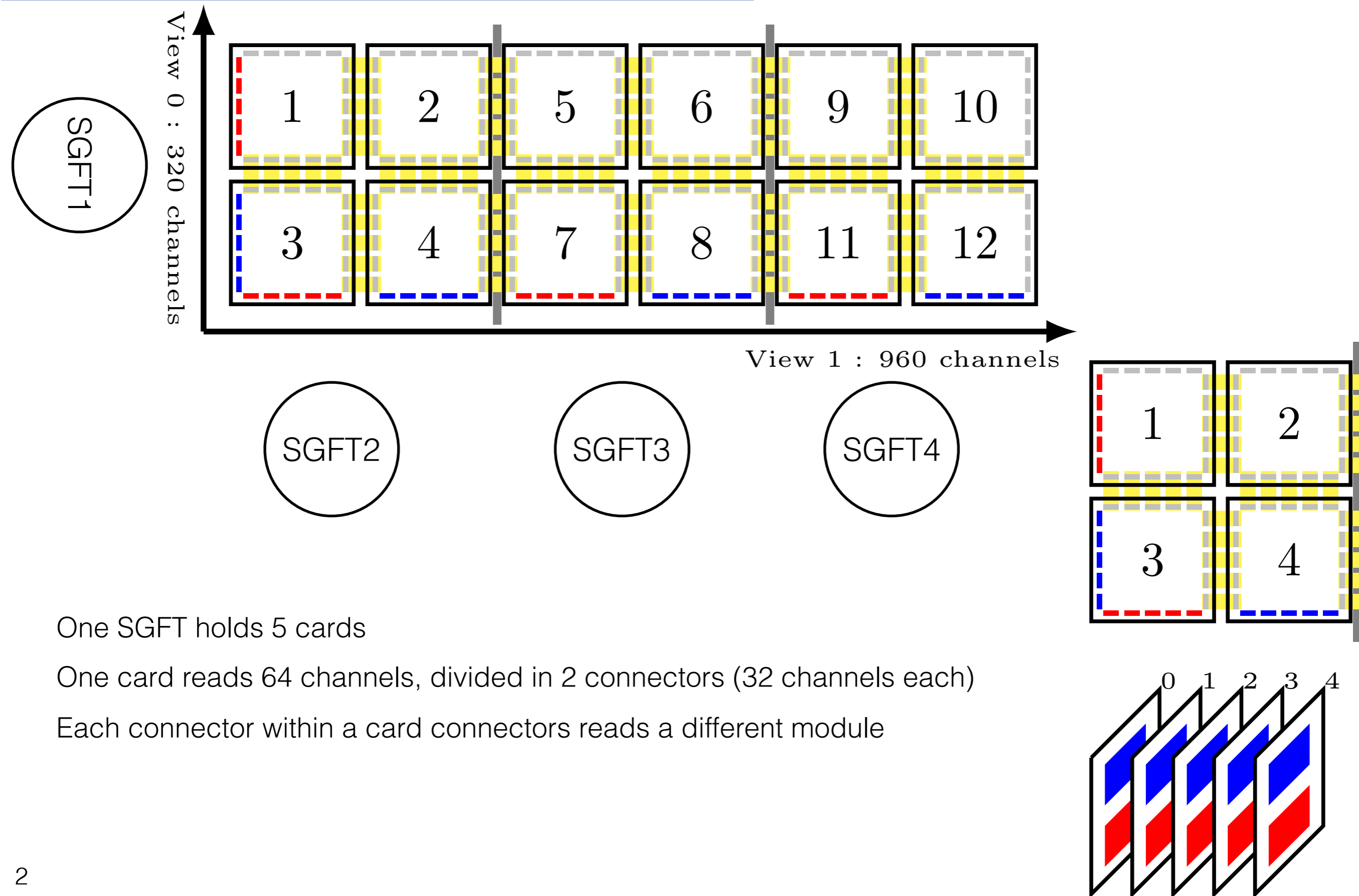
WA105 Collaboration Meeting

22 / 03 / 2017

Laura Zambelli  
for the Laura's team  
(Molina Bueno & Manenti)

(and many others)

# Channel numbering reminder



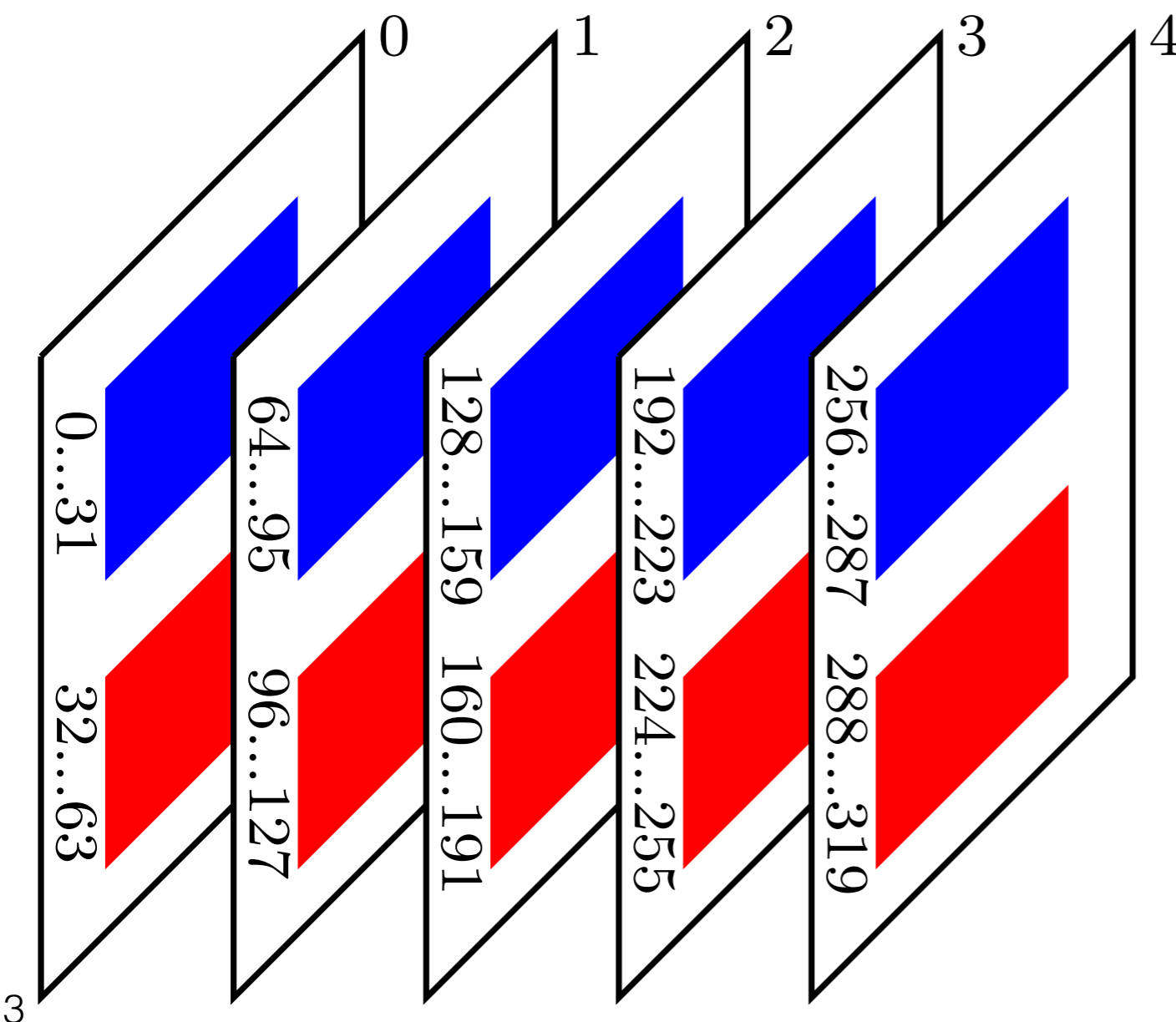
# Channel numbering reminder

## DAQ channels :

→ Counting at the card level

First card, first connector, first channel is DAQ #0

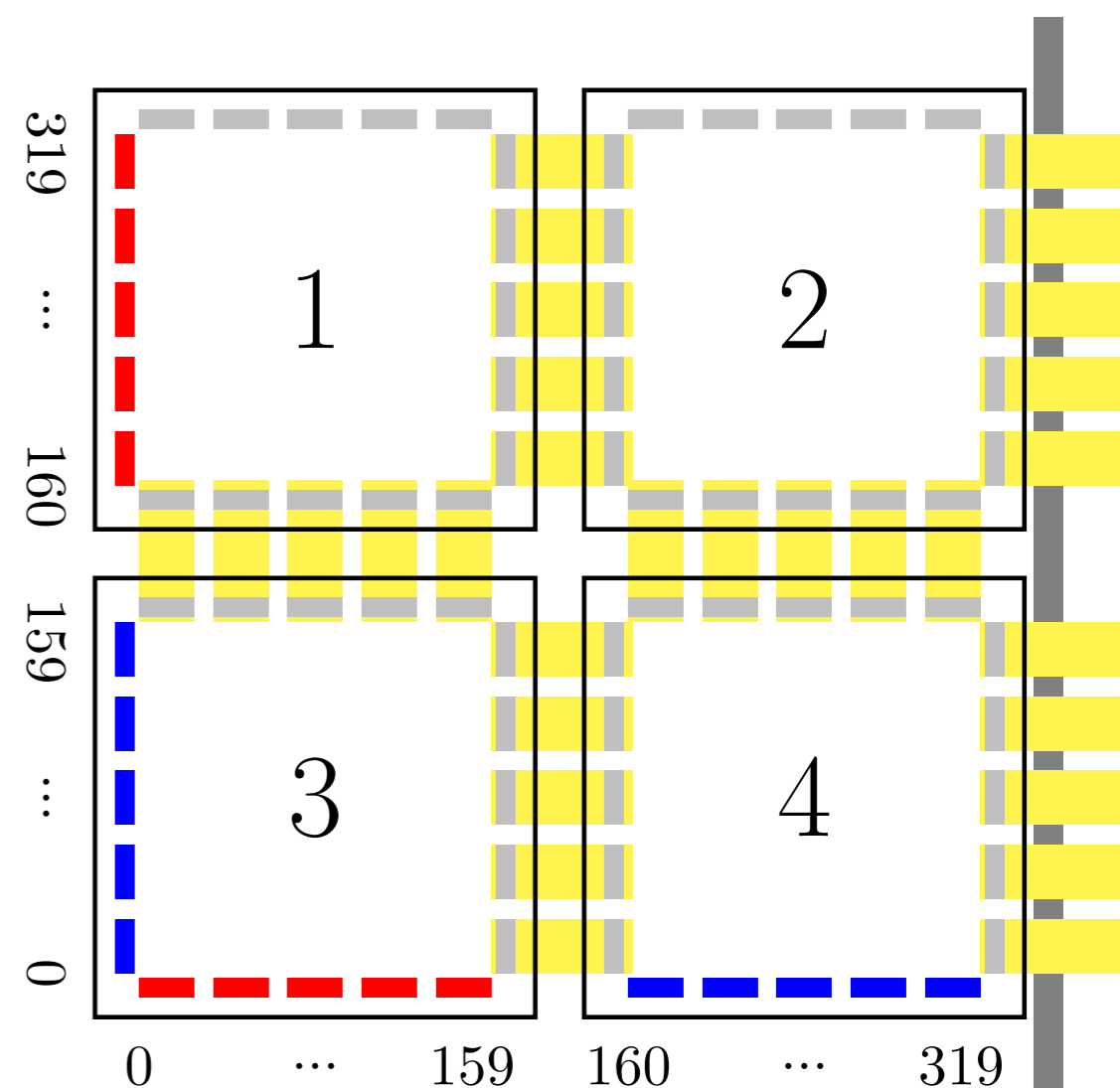
Then DAQ channels increase from top to bottom in each cards.



## View channels :

→ Counting at the CRP level using right-handed coordinates

Origin at module 3 in both views

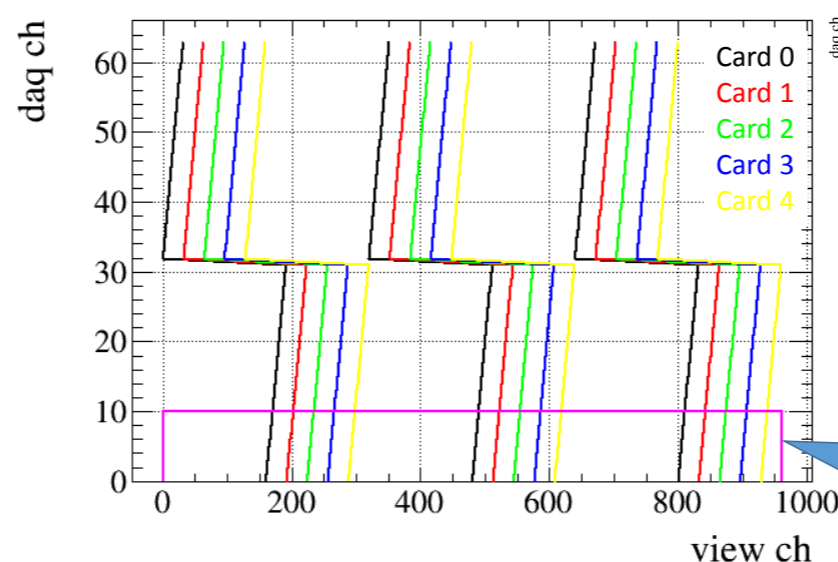
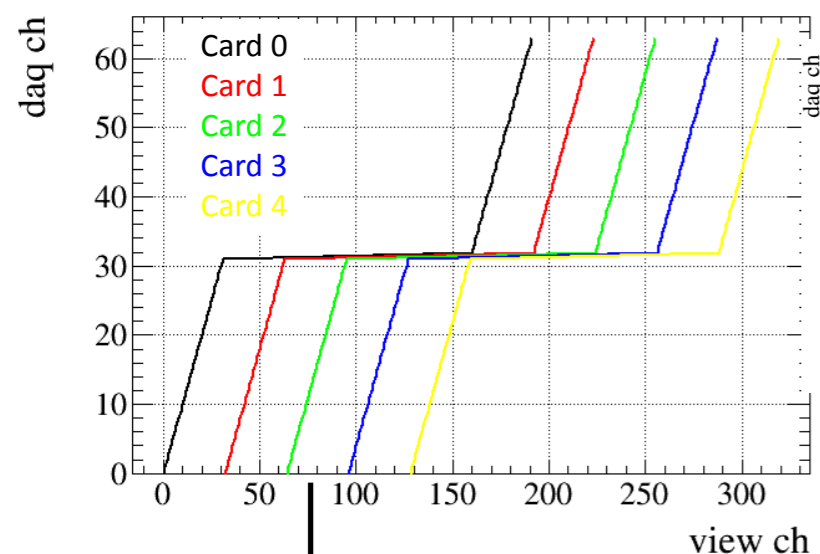
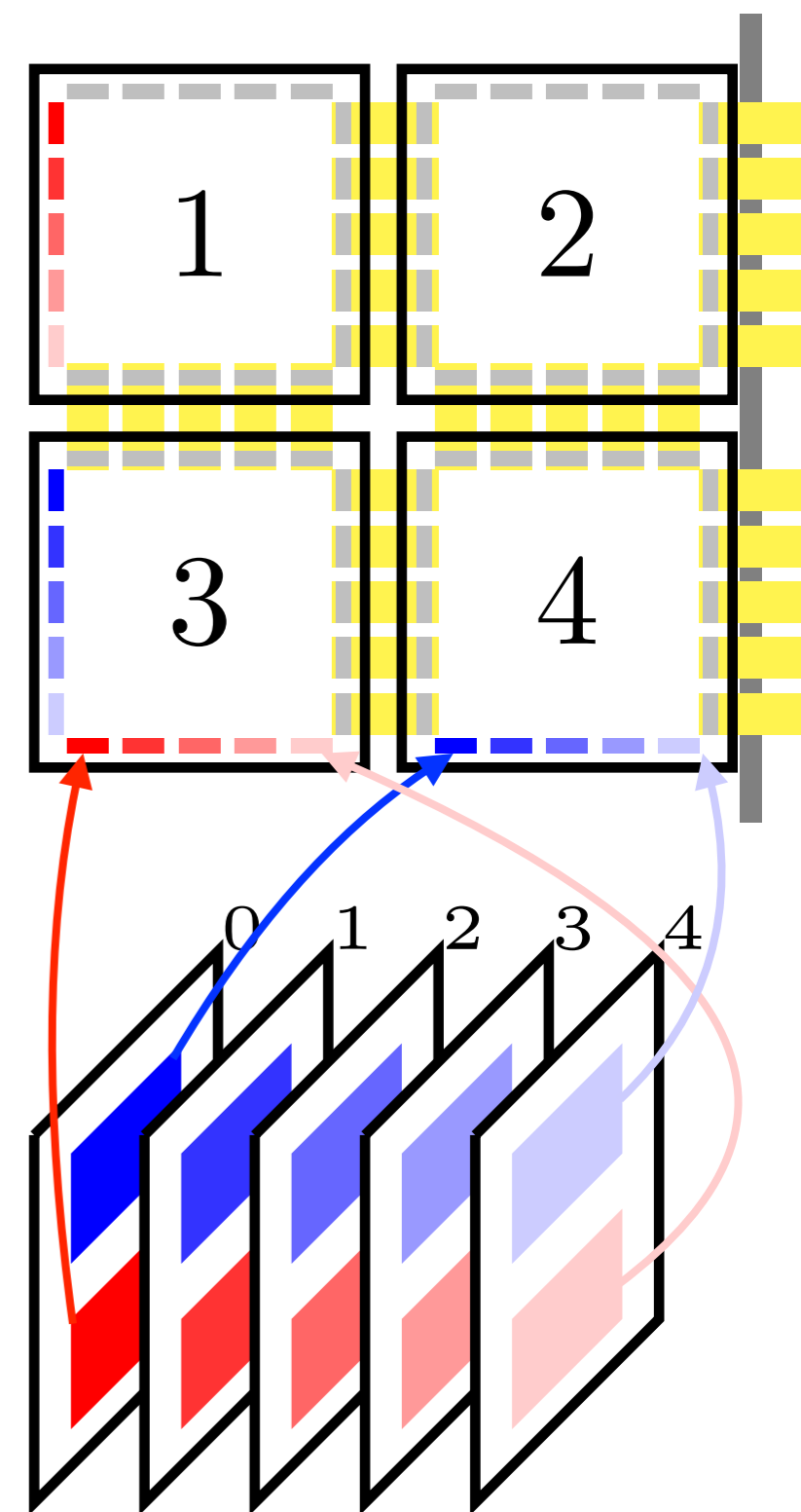


# Channel numbering reminder - Mapping

**Top** connectors reads the lower side (X, view 0) / right side (Y, view 1)

**Bottom** connectors reads the upper side (X, view0) / left side (Y, view 1)

Card	Card channels	DAQ Channels	View Channels X	View Channels Y
0	0~31 (top)	0~31	319~288	160~191
	32~63 (bottom)	32~63	159~128	0~31
4	0~31 (top)	256~287	191~610	288~319
	32~63 (bottom)	288~319	31~0	128~159



4 NB : View 0 channel numbering has been mirrored in order to have right handed coordinates

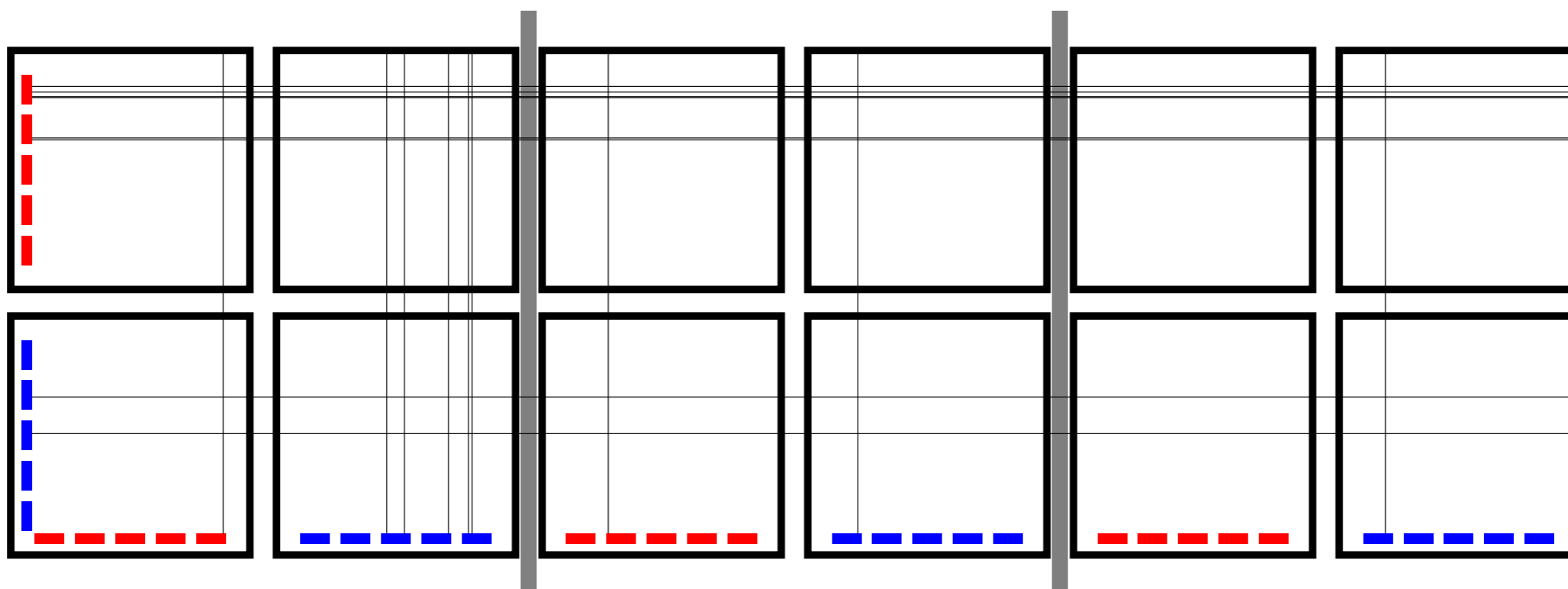
# Problematic channels

As of measurements taken on Dec. 15<sup>th</sup>

View	SGFT	Card	Card Channel	DAQ Channel	View Channel
0	1	2	50	178	77
			5	197	218
		3	7	199	216
			46	238	49
			7	263	184
		4	8	264	183
			13	269	178
			19	275	172

View	SGFT	Card	Card Channel	DAQ Channel	View Channel	
1	2	2	6	454	230	
			25	473	249	
		4	61	637	157	
			29	541	285	
		3	7	583	295	
			11	587	299	
		3	0	28	668	508
			1	34	738	354
	4		0	24	984	824

17 problematic channels out of 1280 → 1.3%



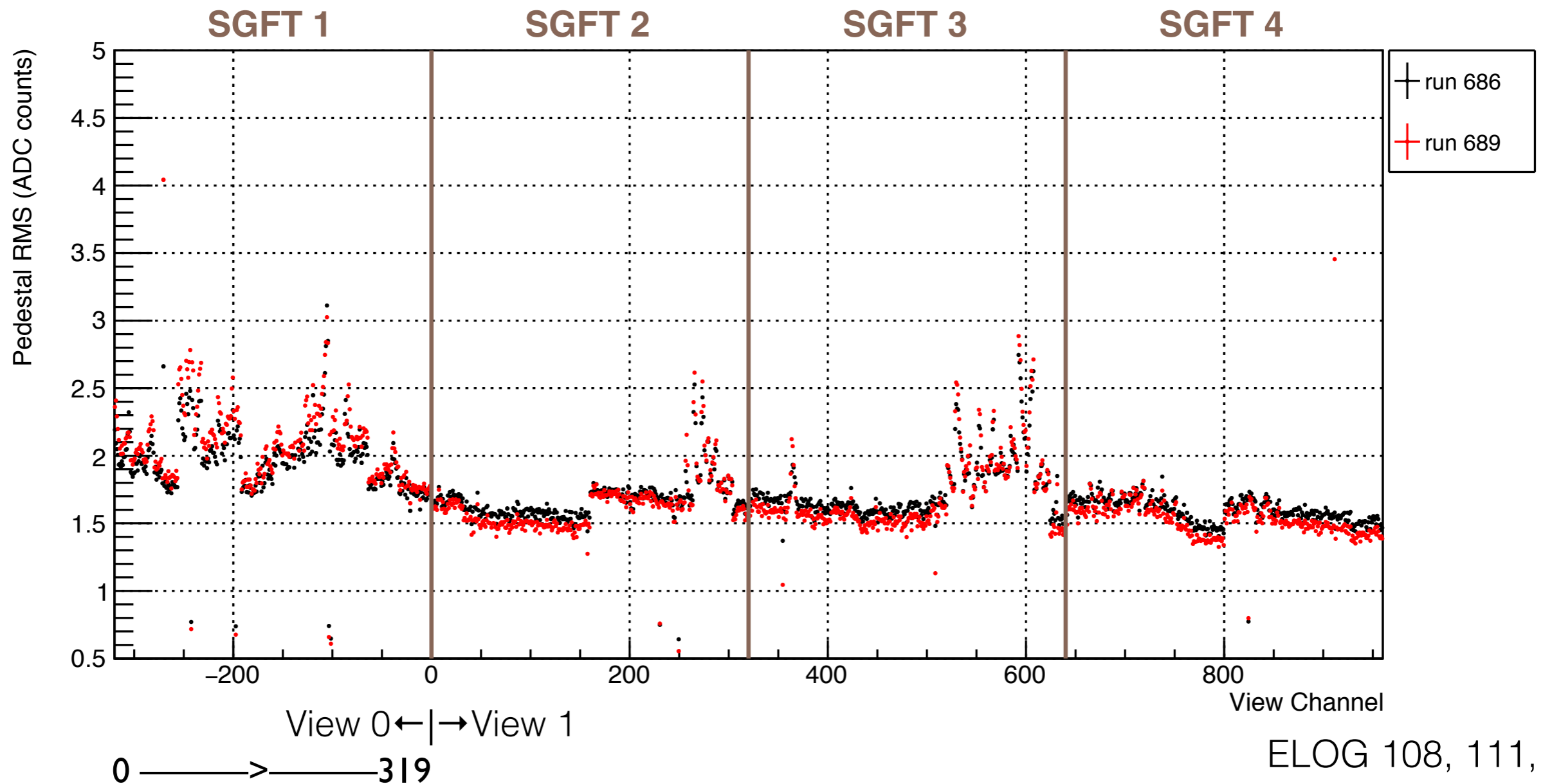
# Noise measurements

With the following conditions :

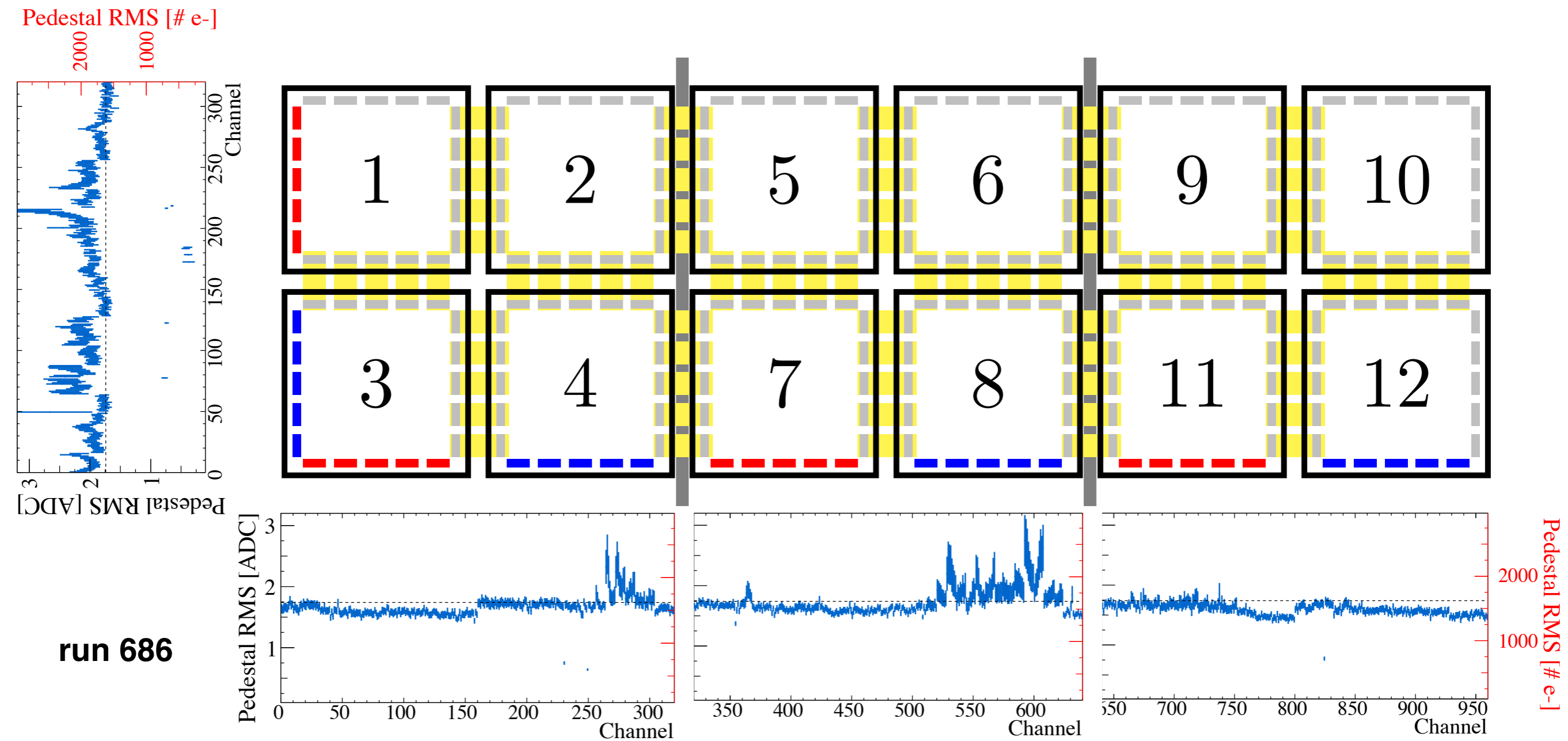
- PMT PS ON at 0V
- LEM PS ON at 0V
- Cathode PS ON at 0V
- T probes and TC connected
- Level Meter connected
- CRP motorization connected, 24V circuit is OFF
- LED & Heaters disconnected
- Camera OFF & disconnected

Lowest noise condition has a pedestal RMS of 1.74 ADC [run 686]

Measurement was reproduced 2 weeks later with same results [run 689]



# Noise measurements



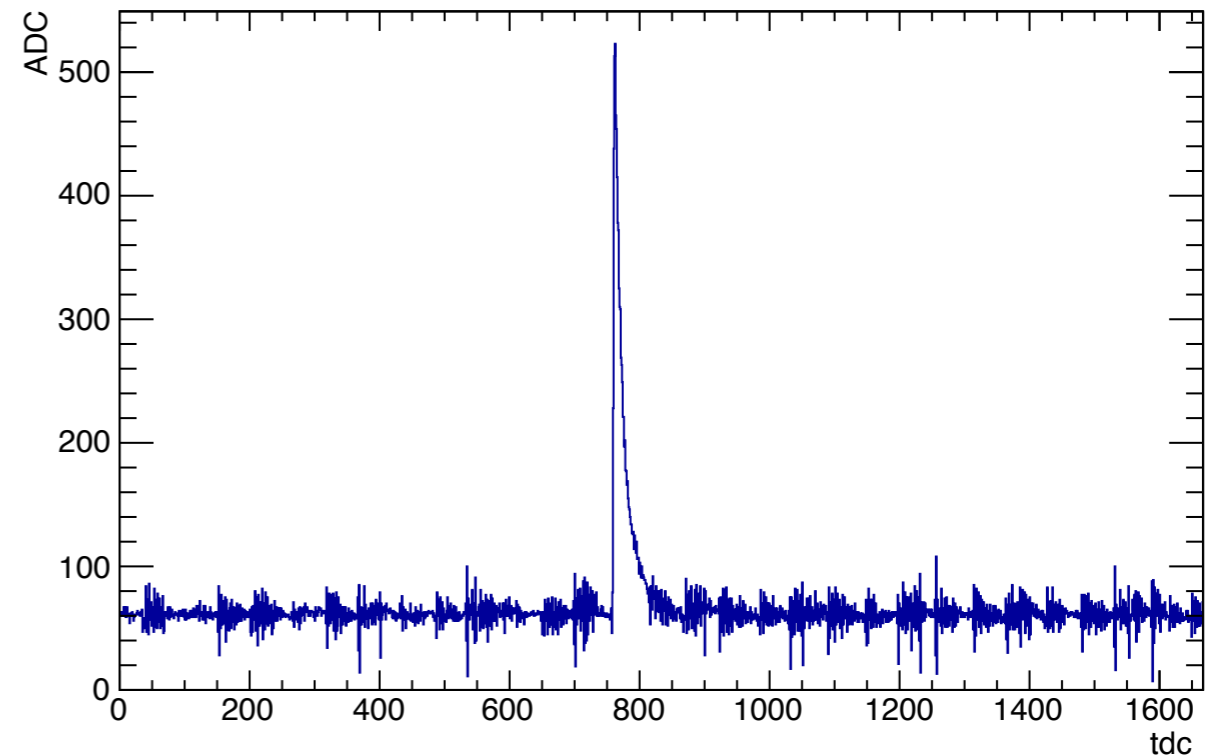
# Pulsed measurements

---

- Pulsing connectors individually (group of 32 channels together).
- Or pulsing 20 connectors at the same time (at the calibration flange level)
- Each pulsing have been performed with an injection of 150 fC [ $\sim 5$ mip]
- Signal contaminated with high frequency noise due to unshielded cable

**run 367**

View channel 544 (pulsed)

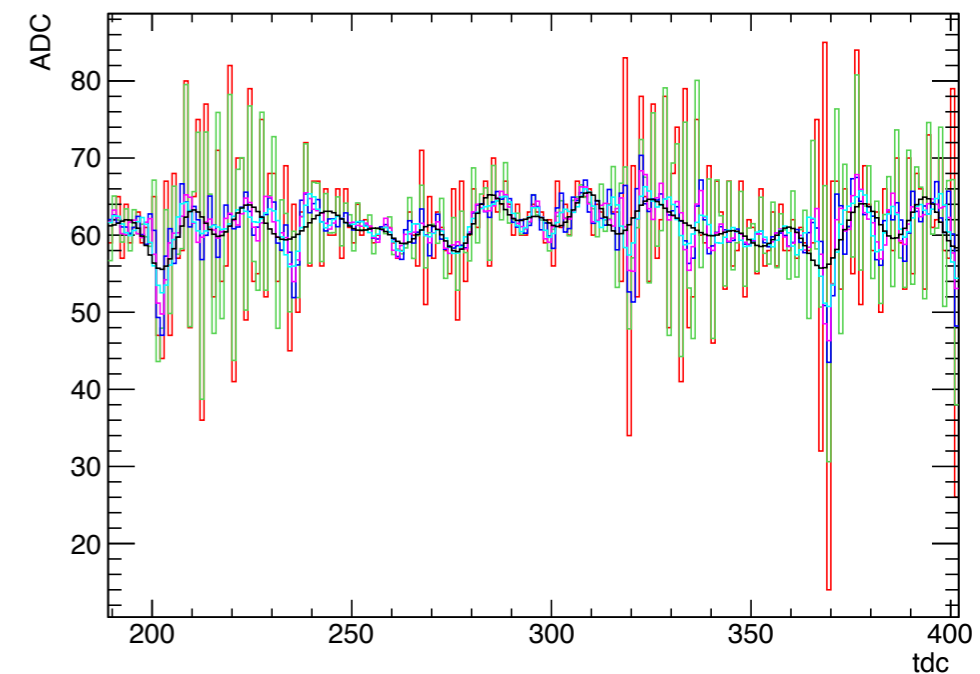
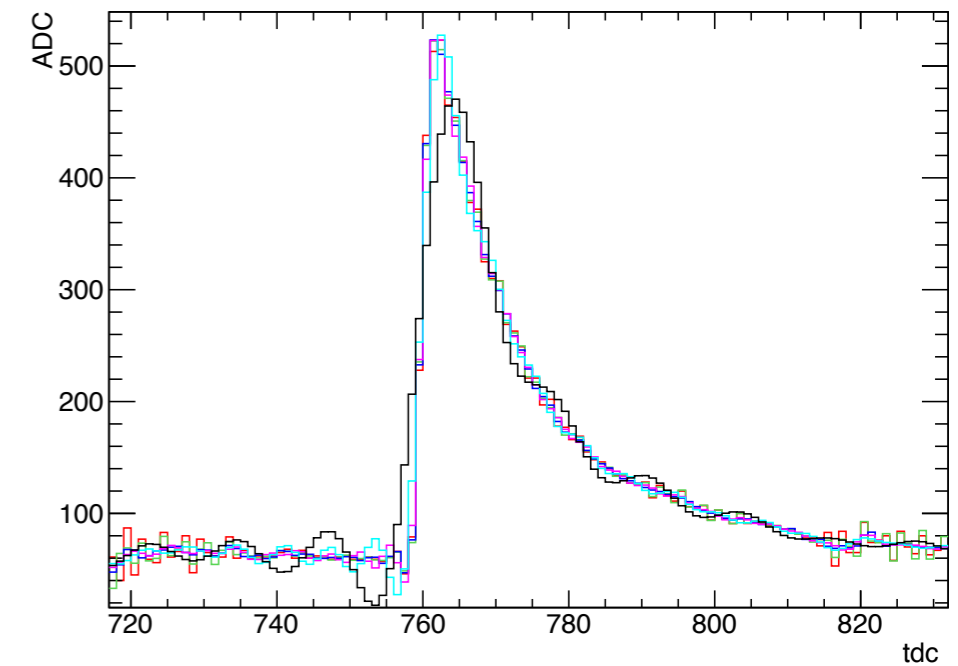
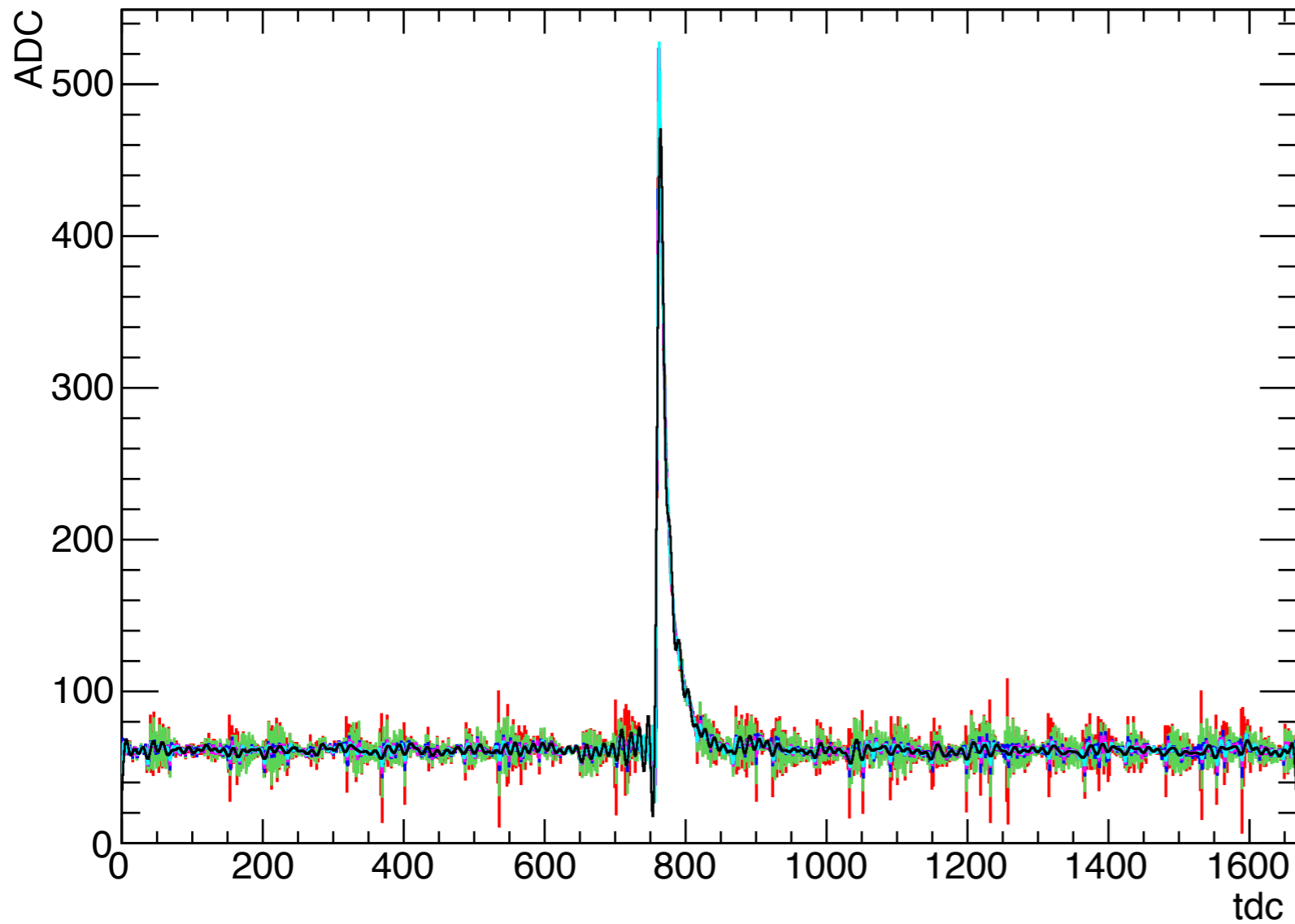




# FFT Filtering

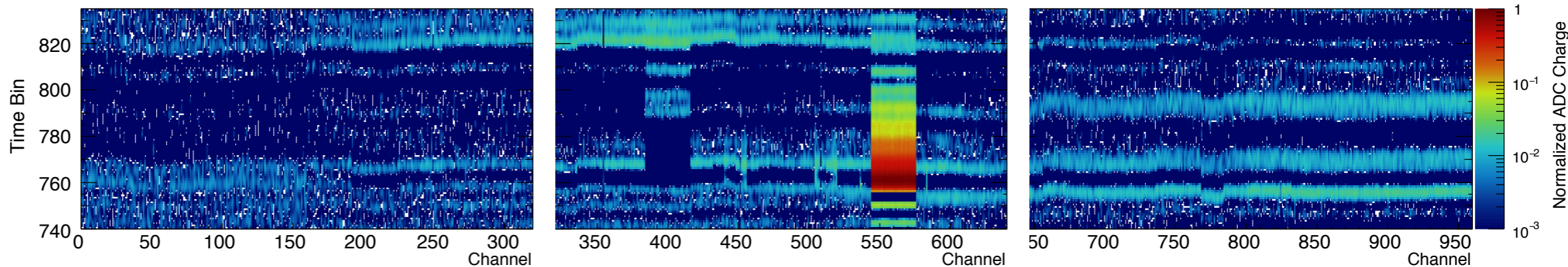
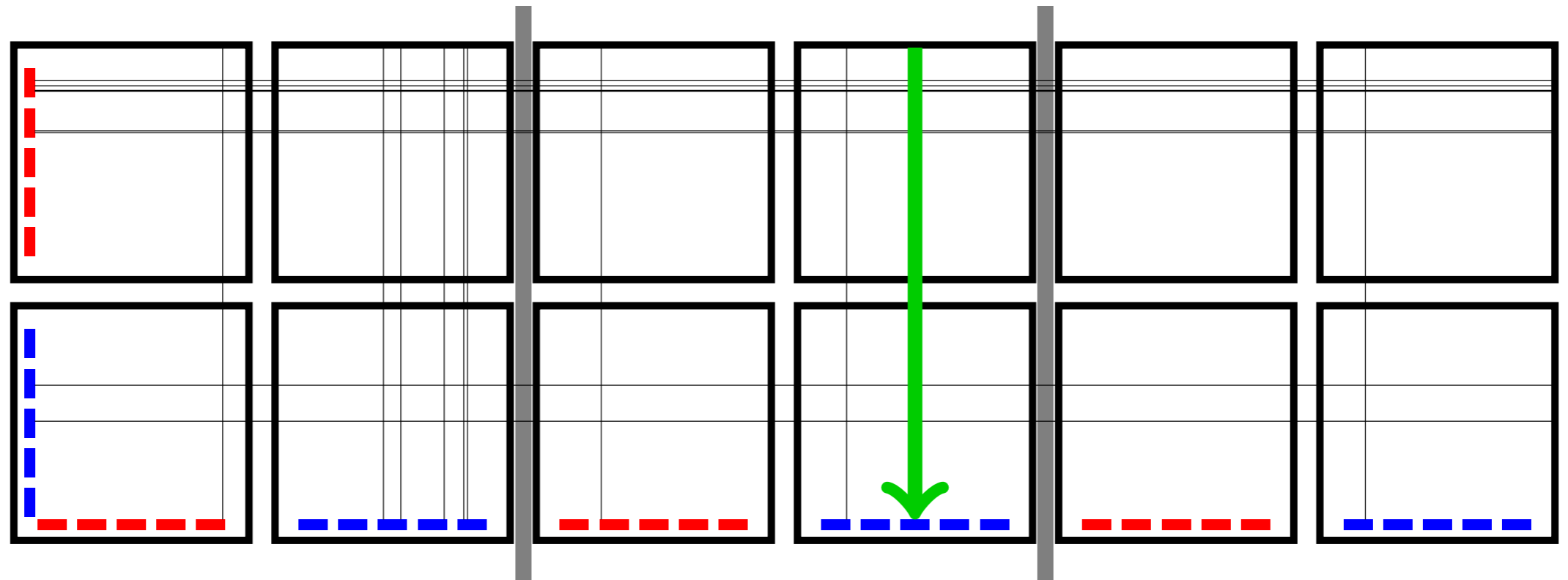
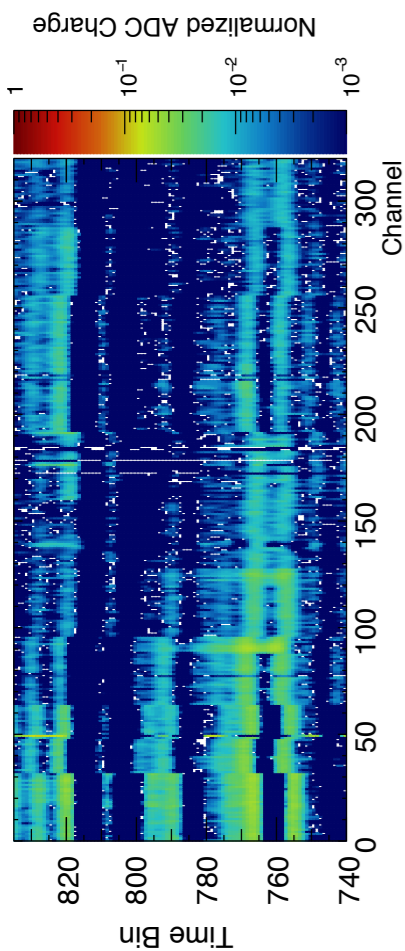
The high frequencies can be easily removed with a cut in Fourier space without affecting the signal

- no cuts
- > 1 MHz cut
- > 0.8 MHz cut
- > 0.6 MHz cut
- > 0.4 MHz cut
- > 0.2 MHz cut



# Pulsed data - single connector pulsed, 2D view

Top connector of card 2 in SGFT 3 is pulsed



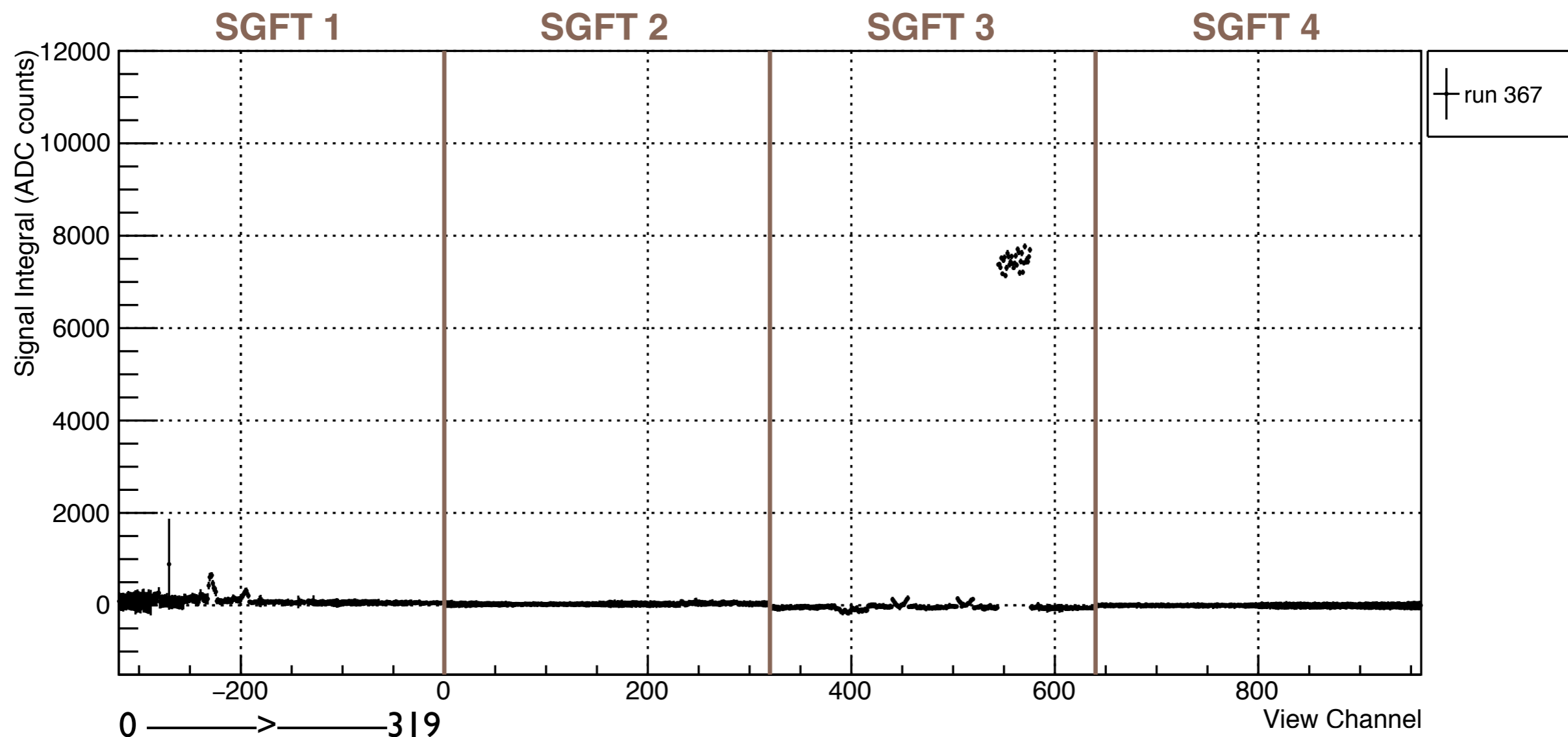
run 367

FFT filtered

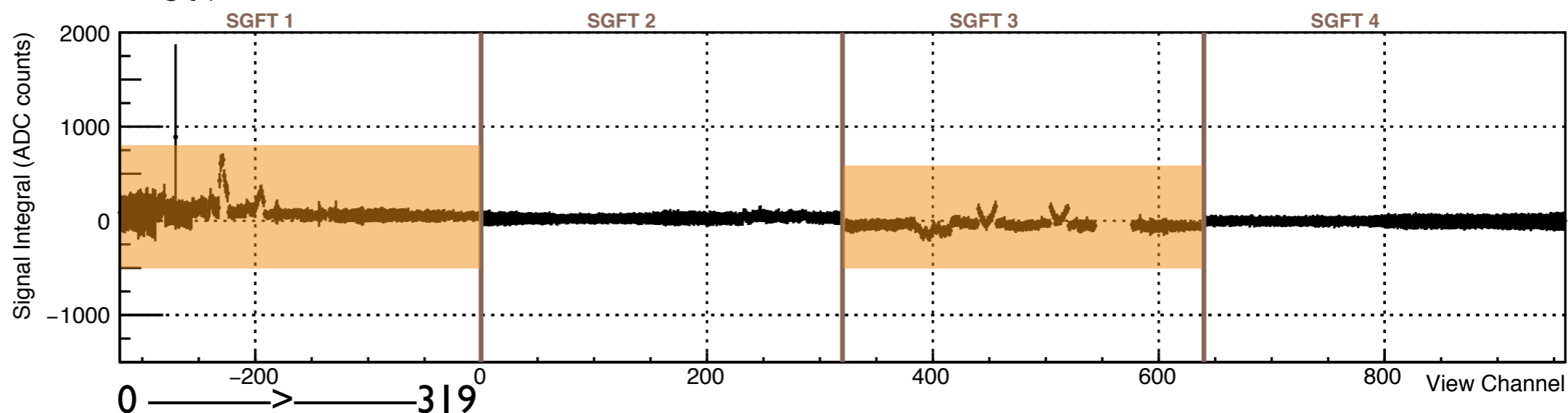
- Some noise remains → The cable has been changed to a shielded one meanwhile
- No strong cross talked observed (roughly 5%, see next slides)
- Counter connector in card seems to react to the pulse
- Characterization of the anode in progress (Pin & Caspar, previous talk)

# Pulsed data - single connector pulsed

Looking at the integral of the waveforms in the pulsing time window in each channel

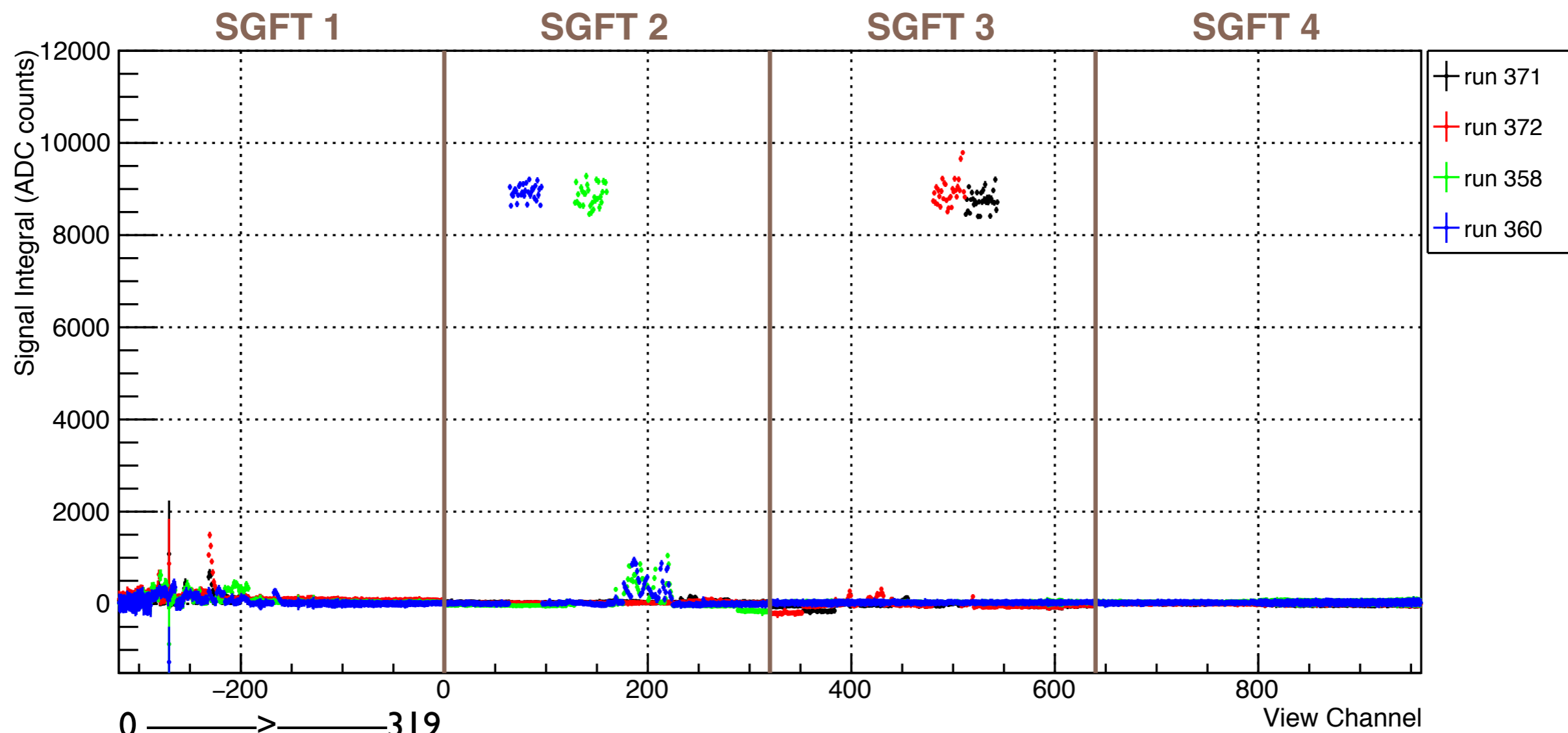


→ Little cross talk  
in the pulsed  
module and in the  
other view

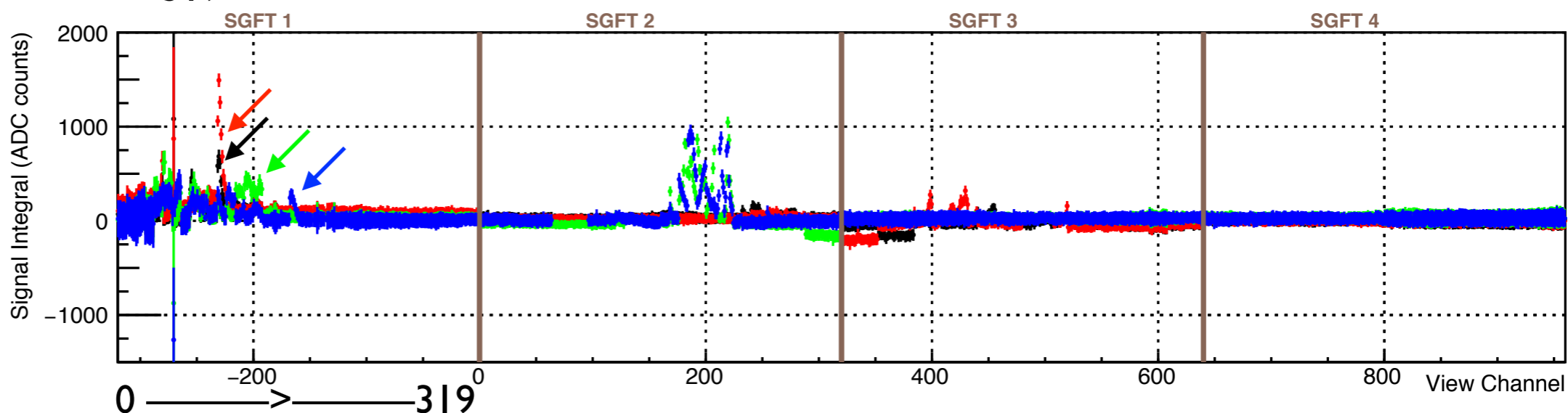


# Pulsed data - Different connectors pulsed

Looking at the integral of the waveforms in the pulsing time window in each channel

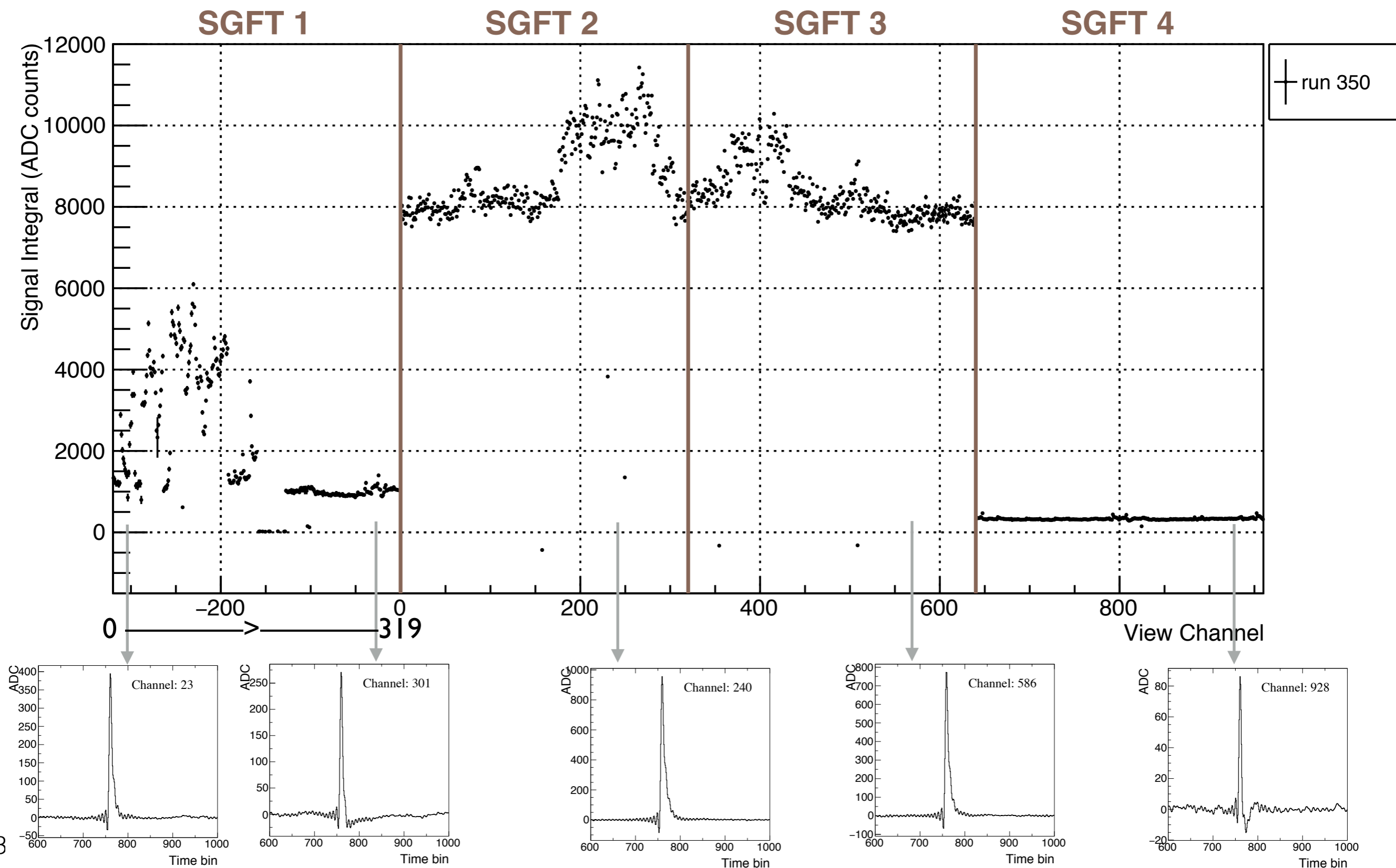


→ The amount of cross talk in the other view seems to be independent from the pulsing position

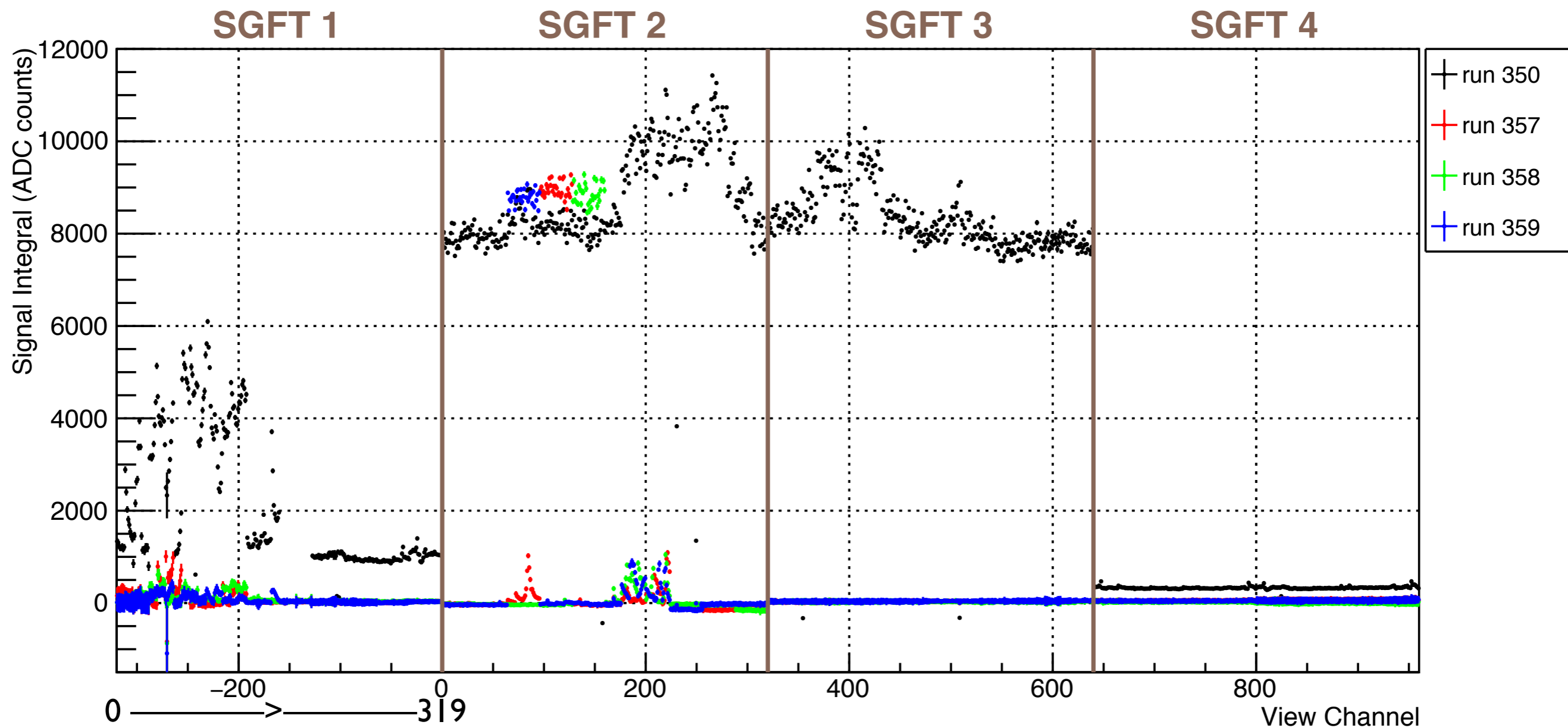


# Pulsed data - All connectors in SGFT 2 & 3 pulsed

Using a different pulsing system, all channels in SGFT 2 & 3 were pulsed



# Pulsed data - All conn. pulsed vs single conn. pulsed



Using a different pulsing system, all channels in SGFT 2 & 3 were pulsed

Compared to single connectors pulsed but the injected signal may be different

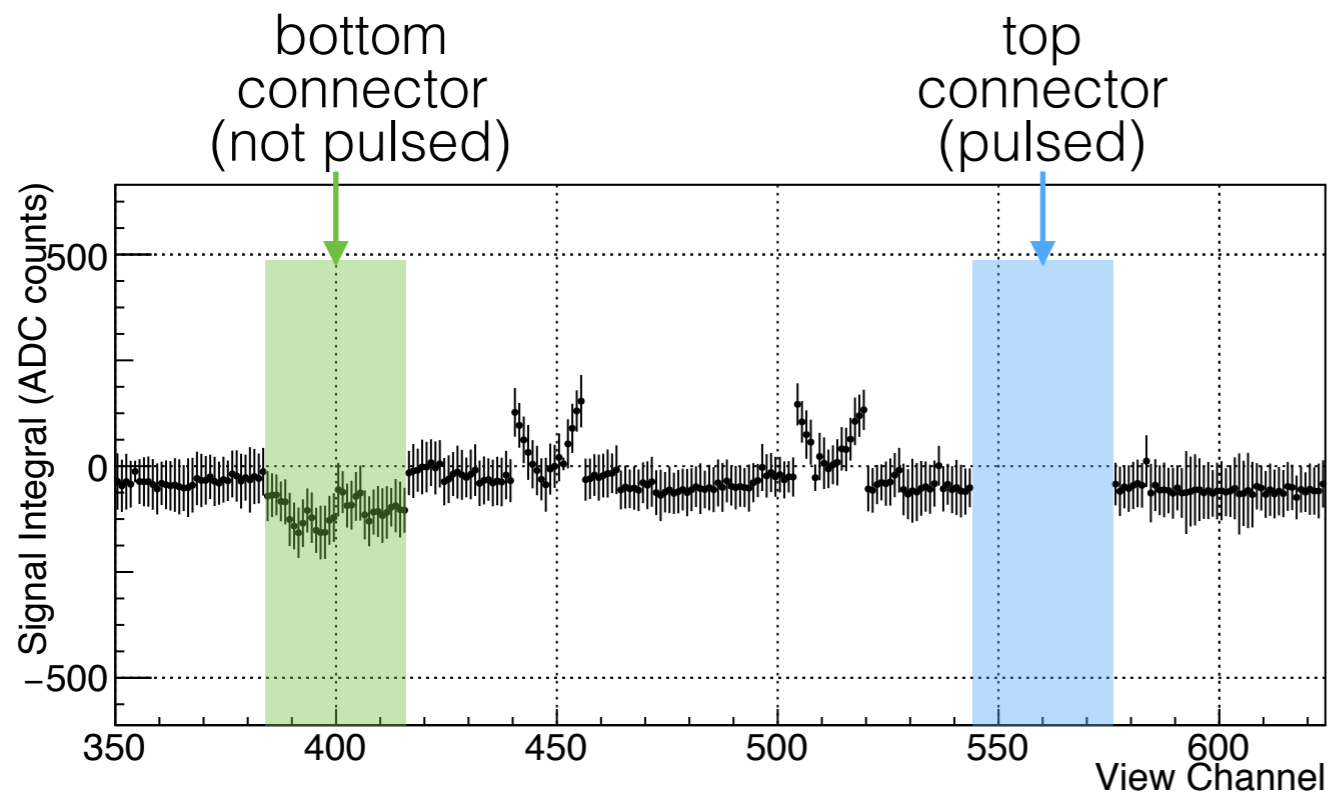
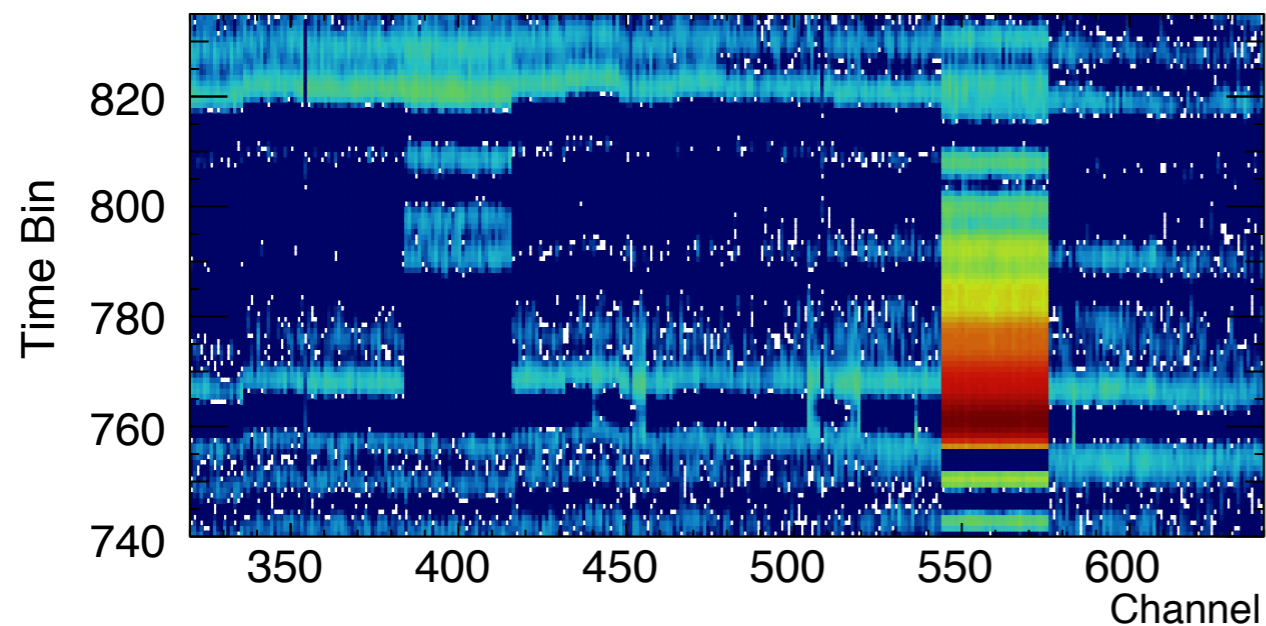
so no conclusions can be drawn from this plot at the moment !



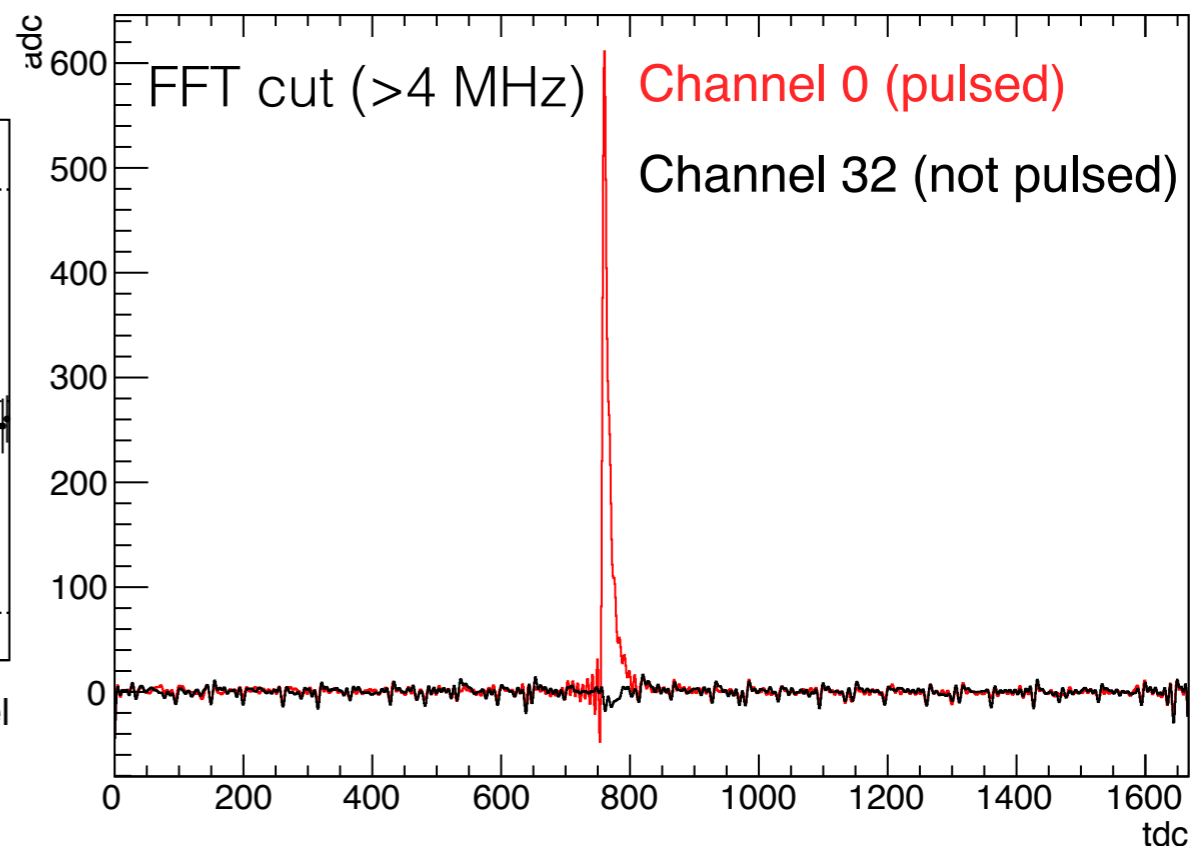
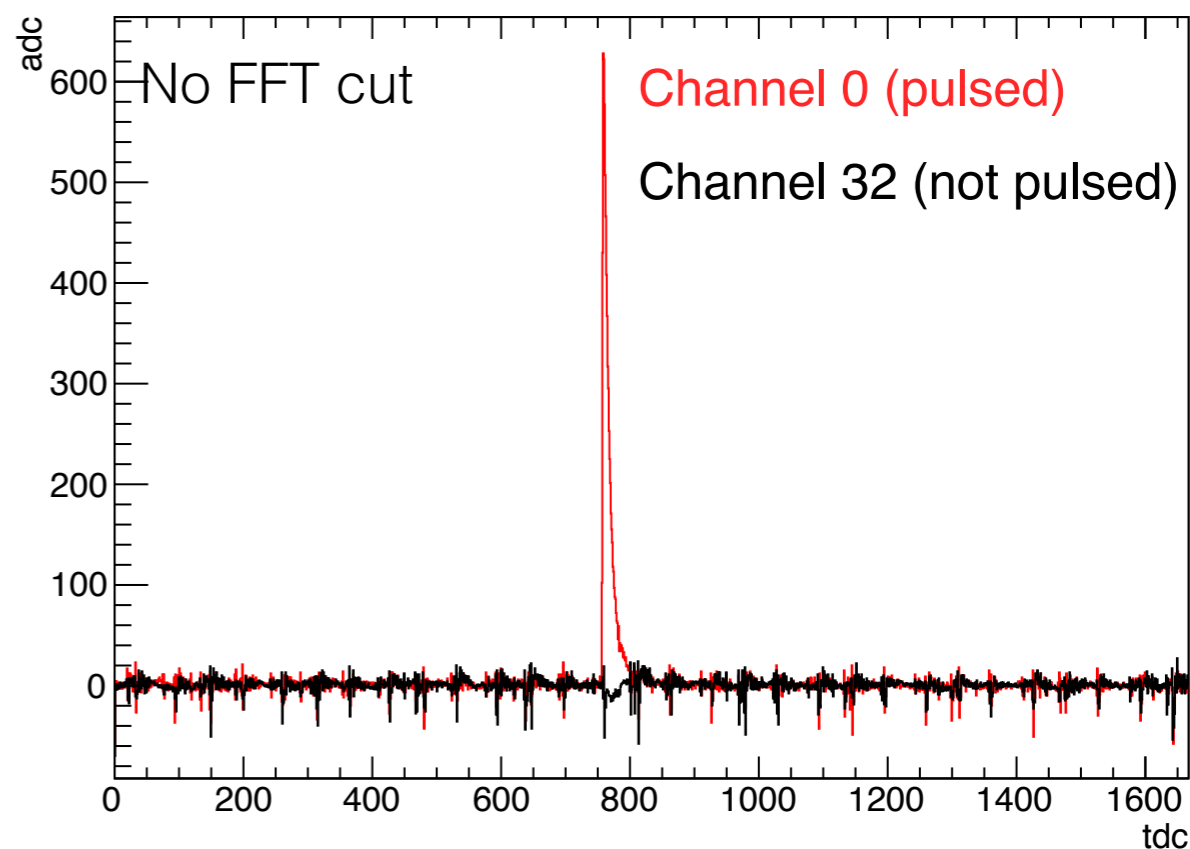
# Pulsed data - Counter reaction in the card ?

Example :

run 367, top connector of card 2 in SGFT 3 is pulsed



anti peak in the other connector ? [ $\sim 1\%$  amplitude]



# Summary

---

- Only 1% of problematic channels observed
- Low noise level measured [ $\sim 1.74$  ADC] and reproduced later
- Pulsed data show a cross talk of about 5%, which needs to be further studied
- Final pulsing system needs to be installed with the new shielded cable
- As we have extra time before data taking, more data should be taken !  
(for example with different charge inputs)